

<b>Notice of References Cited</b>	Application/Control No. 10/582,501		Applicant(s)/Patent Under Reexamination KUNO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0045988	11-2001	Yamauchi et al.	348/273
*	B	US-2004/0085458	05-2004	Yanof et al.	348/223.1
*	C	US-6,493,029 B1	12-2002	Denyer et al.	348/236
*	D	US-6,415,053 B1	07-2002	Norimatsu, Masashi	382/199
*	E	US-6,714,242 B1	03-2004	Kobayashi, Atsushi	348/272
*	F	US-2003/0025814 A1	02-2003	Hunter et al.	348/272
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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